

TEST REPORT

FCC ID: 2AEJAGOLF9
Product: Smart phone

Model No.: F9

Additional Model: Sport

Trade Mark: GOL

Report No.: TCT160322E020

Issued Date: Mar. 31, 2016

Issued for:

GSM GLOBE.COM INC

134 N.E 1 Street, Miami, Florida, United States

Issued By:

Shenzhen Tongce Testing Lab.

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1. Test Certification

Product:	Smart phone
Model No.:	F9 (3)
Additional Model:	Sport
Applicant:	GSM GLOBE.COM INC
Address:	134 N.E 1 Street, Miami, Florida, United States
Manufacturer:	ShenZhen Huanuo Internet Technology Co.,Ltd
Address:	Room 10G, Tower 4C, Software Industry Base, Nanshan District, ShenZhen, China
Date of Test:	Mar. 22 – Mar. 29, 2016
Applicable Standards:	FCC CFR Title 47 Part 15 Subpart C Section 15.247

The above equipment has been tested by Shenzhen Tongce Testing Lab. and found compliance with the requirements set forth in the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Tested By: Mar. 29, 2016

Reviewed By: Date: Mar. 31, 2016

Joe Zhou

Approved By: Date: Mar. 31, 2016

Tomsin



2. Test Result Summary

Requirement	CFR 47 Section	Result
Antenna Requirement	§15.203/§15.247 (c)	PASS
AC Power Line Conducted Emission	§15.207	PASS
Conducted Peak Output Power	§15.247 (b)(1)	PASS
20dB Occupied Bandwidth	§15.247 (a)(1)	PASS
Carrier Frequencies Separation	§15.247 (a)(1)	PASS
Hopping Channel Number	§15.247 (a)(1)	PASS
Dwell Time	§15.247 (a)(1)	PASS
Radiated Emission	§15.205/§15.209	PASS
Band Edge	§15.247(d)	PASS

Note:

- 1. PASS: Test item meets the requirement.
- 2. Fail: Test item does not meet the requirement.
- 3. N/A: Test case does not apply to the test object.
- 4. The test result judgment is decided by the limit of test standard.





3. EUT Description

TESTING	CENTRE	TECHNOLOGY	Report No.: TCT160322	2E020
 - D		4		

Product Name:	Smart phone
Model :	F9
Additional Model:	Sport
Trade Mark:	GOL
Hardware Version:	TS28_V2.0
Software Version:	GOL_F9_S5010B_TS28_HN_VI.00
BT Version:	V2.1+EDR
Operation Frequency:	2402MHz~2480MHz
Transfer Rate:	1/2/3 Mbits/s
Number of Channel:	79
Modulation Type:	GFSK, π/4-DQPSK, 8DPSK
Modulation Technology:	FHSS
Antenna Type:	Internal Antenna
Antenna Gain:	1dBi
Power Supply:	DC 3.7V from rechargeable lithium battery
Remark:	All models above are identical in interior structure, electrical circuits and components, and just model names are different for the marketing requirement.

Operation Frequency each of channel for GFSK, π/4-DQPSK, 8DPSK

Channel	Frequency	Channel	Frequency	Channel	Frequency	Channel	Frequency	
0	2402MHz	20	2422MHz	40	2442MHz	60	2462MHz	
1	2403MHz	21	2423MHz	41	2443MHz	61	2463MHz	
D			<)	X		&	
10	2412MHz	30	2432MHz	50	2452MHz	70	2472MHz	
11	2413MHz	31	2433MHz	51	2453MHz	71	2473MHz	
	ζĠ`)	(ζĊ`)		(c)		(c))	
18	2420MHz	38	2440MHz	58	2460MHz	78	2480MHz	
19	2421MHz	39	2441MHz	59	2461MHz		-	
	Remark: Channel 0, 39 &78 have been tested for GFSK, π/4-DQPSK, 8DPSK modulation mode.							



4. Genera Information

4.1. Test environment and mode

Operating Environment:	
Temperature:	25.0 °C
Humidity:	56 % RH
Atmospheric Pressure:	1010 mbar
Test Mode:	
Engineering mode:	Keep the EUT in continuous transmitting by select channel and modulations

The sample was placed 0.8m above the ground plane of 3m chamber. Measurements in both horizontal and vertical polarities were performed. During the test, each emission was maximized by: having the EUT continuously working, investigated all operating modes, rotated about all 3 axis (X, Y & Z) and considered typical configuration to obtain worst position, manipulating interconnecting cables, rotating the turntable, varying antenna height from 1m to 4m in both horizontal and vertical polarizations. The emissions worst-case are shown in Test Results of the following pages.

4.2. Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
1 (6)	I ((d) 1	<u>(3)</u> 1	(3)

Note:

- 1. All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- 2. Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.
- 3. For conducted measurements (Output Power, 20dB Occupied Bandwidth, Carrier Frequencies Separation, Hopping Channel Number, Dwell Time, Spurious Emissions), the antenna of EUT is connected to the test equipment via temporary antenna connector, the antenna connector is soldered on the antenna port of EUT, and the temporary antenna connector is listed in the Test Instruments.

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5. Facilities and Accreditations

5.1. Facilities

The test facility is recognized, certified, or accredited by the following organizations:

FCC - Registration No.: 572331

Shenzhen Tongce Testing Lab

The 3m Semi-anechoic chamber has been registered and fully described in a report with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files.

• IC - Registration No.: 10668A-1

The 3m Semi-anechoic chamber of Shenzhen TCT Testing Technology Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for radio equipment testing

CNAS - Registration No.: CNAS L6165
 Shenzhen TCT Testing Technology Co., Ltd. is accredited to ISO/IEC 17025:2005
 General Requirements for the Competence of Testing and Calibration laboratories for the competence of testing. The Registration No. is CNAS L6165.

5.2. Location

Shenzhen Tongce Testing Lab

Address: 1F, Leinuo Watch Building, Fuyong Town, Baoan Dist, Shenzhen, China

Tel: 86-755-36638142

5.3. Measurement Uncertainty

The reported uncertainty of measurement y ± U, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of k=2, providing a level of confidence of approximately 95 %.

No.	Item	MU
1	Conducted Emission	±2.56dB
2	RF power, conducted	±0.12dB
3	Spurious emissions, conducted	±0.11dB
4	All emissions, radiated(<1G)	±3.92dB
5	All emissions, radiated(>1G)	±4.28dB
6	Temperature	±0.1°C
7	Humidity	±1.0%

Report No.: TCT160322E020



6. Test Results and Measurement Data

6.1. Antenna requirement

Standard requirement: FCC Part15 C Section 15.203 /247(c)

15.203 requirement:

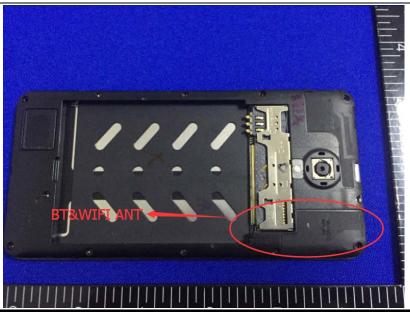
An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.

15.247(c) (1)(i) requirement:

(i) Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6dBi.

E.U.T Antenna:

The EUT antenna is an internal antenna which permanently attached, and the best case gain of the antenna is 1dBi.





6.2. Conducted Emission

6.2.1. Test Specification

<u> </u>								
Test Requirement:	FCC Part15 C Section 15.207							
Test Method:	ANSI C63.10:2013	ANSI C63.10:2013						
Frequency Range:	150 kHz to 30 MHz	150 kHz to 30 MHz						
Receiver setup:	RBW=9 kHz, VBW=30 kHz, Sweep time=auto							
	Frequency range	Limit (dBuV)					
	(MHz)	Quasi-peak	Average					
Limits:	0.15-0.5	66 to 56*	56 to 46*					
	0.5-5	56	46					
	5-30	60	50					
	Reference	e Plane						
Test Setup:	AC power E.U.T AC power Filter AC power							
Test Mode:	Refer to item 4.1							
Test Procedure:	 The E.U.T and simulators are connected to the main power through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm/50uH coupling impedance for the measuring equipment. The peripheral devices are also connected to the main power through a LISN that provides a 50ohm/50uH coupling impedance with 50ohm termination. (Please refer to the block diagram of the test setup and photographs). Both sides of A.C. line are checked for maximum conducted interference. In order to find the maximum emission, the relative positions of equipment and all of the interface cables must be changed according to ANSI C63.10: 2013 on conducted measurement. 							
Test Result:	PASS							



6.2.2. Test Instruments

Cond	Conducted Emission Shielding Room Test Site (843)									
Equipment	Manufacturer	Model	Serial Number	Calibration Due						
EMI Test Receiver	R&S	ESCS30	100139	Sep. 11, 2016						
LISN	Schwarzbeck	NSLK 8126	8126453	Sep. 16, 2016						
Coax cable	TCT	CE-05	N/A	Sep. 11, 2016						
EMI Test Software	Shurple Technology	EZ-EMC	N/A	N/A						



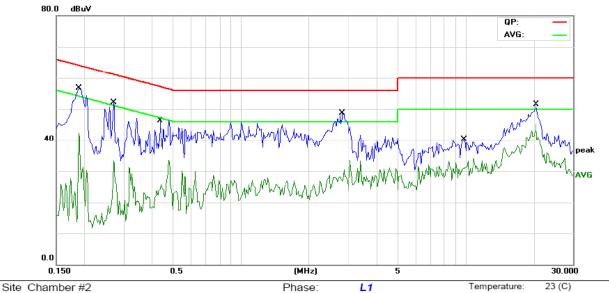




6.2.3. Test data

Please refer to following diagram for individual

Conducted Emission on Line Terminal of the power line (150 kHz to 30MHz)



Limit: FCC Part 15B Class B Conduction(QP)

AC 120V/60Hz Power:

Humidity:

Reading Correct Measure-Limit Over No. Mk. Freq. Level Factor ment MHz dBuV dB dBuV dBuV dB Detector Comment 0.1891 28.51 11.47 39.98 64.07 -24.09 QΡ 1 2 0.1891 10.40 11.47 21.87 54.07 -32.20 AVG 3 0.2711 30.39 11.42 41.81 61.08 -19.27 QP 4 0.2711 13.06 11.42 24.48 51.08 -26.60 AVG 5 0.4352 28.83 11.33 40.16 57.15 -16.99 QΡ 6 0.4352 13.82 11.33 25.15 47.15 -22.00 AVG 7 56.00 -17.48 QP 2.8219 27.13 11.39 38.52 8 2.8219 14.81 11.39 26.20 46.00 -19.80 AVG 9 9.8516 21.23 11.31 32.54 60.00 -27.46 QΡ 50.00 -24.87 AVG 10 9.8516 13.82 11.31 25.13 11 20.6484 33.72 10.56 44.28 60.00 -15.72 QΡ 12 20.6484 25.70 10.56 36.26 50.00 -13.74 AVG

Note:

Freq. = Emission frequency in MHz

Reading level $(dB\mu V)$ = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss

Measurement $(dB\mu V)$ = Reading level $(dB\mu V)$ + Corr. Factor (dB)

Limit $(dB\mu V) = Limit$ stated in standard

 $Margin (dB) = Measurement (dB\mu V) - Limits (dB\mu V)$

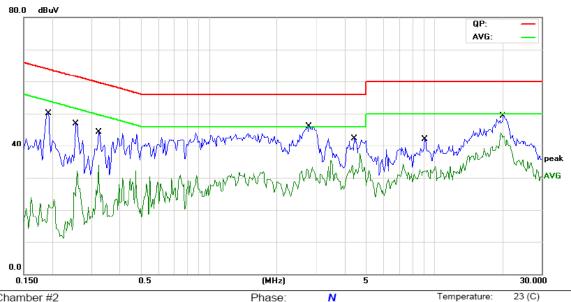
Q.P. =Quasi-Peak

AVG =average

^{*} is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz



Conducted Emission on Neutral Terminal of the power line (150 kHz to 30MHz)



Site Chamber #2 Phase: N Temperature: 23 (C)
Limit: FCC Part 15B Class B Conduction(QP) Power: AC 120V/60Hz Humidity: 54 %

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1		0.1930	31.06	11.48	42.54	63.90	-21.36	QP		
2		0.1930	12.58	11.48	24.06	53.90	-29.84	AVG		
3		0.2555	27.15	11.45	38.60	61.57	-22.97	QP		
4		0.2555	13.68	11.45	25.13	51.57	-26.44	AVG		
5		0.3219	26.77	11.42	38.19	59.66	-21.47	QP		
6		0.3219	13.59	11.42	25.01	49.66	-24.65	AVG		
7		2.7788	27.38	11.41	38.79	56.00	-17.21	QP		
8		2.7788	17.60	11.41	29.01	46.00	-16.99	AVG		
9		4.4219	24.89	10.83	35.72	56.00	-20.28	QP		
10		4.4219	15.07	10.83	25.90	46.00	-20.10	AVG		
11		9.1055	22.48	11.23	33.71	60.00	-26.29	QP		
12		9.1055	13.87	11.23	25.10	50.00	-24.90	AVG		
13		20.2383	33.41	10.57	43.98	60.00	-16.02	QP		

Note1:

Freq. = Emission frequency in MHz

Reading level $(dB\mu V)$ = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss

Measurement $(dB\mu V)$ = Reading level $(dB\mu V)$ + Corr. Factor (dB)

 $Limit (dB\mu V) = Limit stated in standard$

Margin (dB) = Measurement (dB μ V) – Limits (dB μ V)

Q.P. =Quasi-Peak AVG =average

* is meaning the worst frequency has been tested in the frequency range 150 kHz to 30MHz.

Note2:

Measurements were conducted in all three channels (high, middle, low) and three modulation (GFSK, Pi/4 DQPSK, 8DPSK), and the worst case Mode (Low channel and Pi/4 DQPSK) was submitted only.



6.3. Conducted Output Power

6.3.1. Test Specification

(30)	(20)				
Test Requirement:	FCC Part15 C Section 15.247 (b)(3)				
Test Method:	ANSI C63.10:2013 and DA00-705				
Limit:	Section 15.247 (b) The maximum peak conducted output power of the intentional radiator shall not exceed the following: (1) For frequency hopping systems operating in the 2400-2483.5 MHz band employing at least 75 non-overlapping hopping channels, and all frequency hopping systems in the 5725-5850 MHz band: 1 watt. For all other frequency hopping systems in the 2400-2483.5 MHz band 0.125 watts.				
Test Setup:	Spectrum Analyzer EUT				
Test Mode:	Transmitting mode with r	modulation			
Test Procedure:	centered on a hopping content of RBW > the 20 dB bar measured VBW ≥ RBW Sweep = auto Detector function = peak Trace = max hold Allow the trace to stabilize	5 times the 20 dB bandwidth, hannel ndwidth of the emission being			
Test Result:	PASS				

6.3.2. Test Instruments

Equipment	Manufacturer	Model	Serial Number	Calibration Due
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016
RF Cable	TCT	RE-06	N/A	Sep. 12, 2016
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016



6.4. 20dB Occupy Bandwidth

6.4.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)				
Test Method:	ANSI C63.10:2013 and DA00-705				
Limit:	N/A				
Test Setup:	Spectrum Analyzer EUT				
Test Mode:	Transmitting mode with modulation				
Test Procedure:	 The testing follows FCC Public Notice DA 00-705 Measurement Guidelines. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Use the following spectrum analyzer settings for 20dB Bandwidth measurement. Span = approximately 2 to 3 times the 20 dB bandwidth, centered on a hopping channel; RBW≥1% of the 20 dB bandwidth; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold. Measure and record the results in the test report. 				
Test Result:	PASS				

6.4.2. Test Instruments

RF Test Room					
Equipment Manufacturer Model Serial Number Calibration Due					
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016	
RF cable	TCT	RE-06	N/A	Sep. 12, 2016	
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016	



6.5. Carrier Frequencies Separation

6.5.1. Test Specification

	/ ^ / ^ / ^ / ^ / / / / / / / / / / / /				
Test Requirement:	FCC Part15 C Section 15.247 (a)(1)				
Test Method:	ANSI C63.10:2013 and DA00-705				
Limit:	Frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater.				
Test Setup:	Spectrum Andrews EUT				
	Spectrum Analyzer				
Test Mode:	Hopping mode				
Test Procedure:	 The testing follows FCC Public Notice DA 00-705 Measurement Guidelines. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Enable the EUT hopping function. Use the following spectrum analyzer settings: Span = wide enough to capture the peaks of two adjacent channels; RBW≥1% of the span; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold. Measure and record the results in the test report. 				
Test Result:	PASS				

6.5.2. Test Instruments

RF Test Room					
Equipment Manufacturer Model Serial Number Calibration Due					
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016	
RF cable	TCT	RE-06	N/A	Sep. 12, 2016	
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016	



6.6. Hopping Channel Number

6.6.1. Test Specification

FCC Part15 C Section 15.247 (a)(1)				
ANSI C63.10:2013 and DA00-705				
Frequency hopping systems in the 2400-2483.5 MHz band shall use at least 15 channels.				
Spectrum Analyzer EUT				
Hopping mode				
 The testing follows FCC Public Notice DA 00-705 Measurement Guidelines. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Enable the EUT hopping function. Use the following spectrum analyzer settings: Span = the frequency band of operation; RBW ≥1% of the span; VBW≥RBW; Sweep = auto; Detector function = peak; Trace = max hold. The number of hopping frequency used is defined as the number of total channel. Record the measurement data derived from spectrum analyzer. 				
PASS				

6.6.2. Test Instruments

RF Test Room					
Equipment Manufacturer Model Serial Number Calibration Due					
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016	
RF cable	тст	RE-06	N/A	Sep. 12, 2016	
Antenna Connector	TCT	RFC-01	N/A	Sep. 12, 2016	



6.7. Dwell Time

6.7.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (a)(1)			
Test Method:	ANSI C63.10:2013 and DA00-705			
Limit:	The average time of occupancy on any channel shall not be greater than 0.4 seconds within a period of 0.4 seconds multiplied by the number of hopping channels employed.			
Test Setup:	Spectrum Analyzer EUT			
Test Mode:	Hopping mode			
Test Procedure:	 The testing follows FCC Public Notice DA 00-705 Measurement Guidelines. The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Enable the EUT hopping function. Use the following spectrum analyzer settings: Span = zero span, centered on a hopping channel; RBW = 1 MHz; VBW≥RBW; Sweep = as necessary to capture the entire dwell time per hopping channel; Detector function = peak; Trace = max hold. Measure and record the results in the test report. 			
Test Result:	PASS			
rest Result:	PASS			

6.7.2. Test Instruments

RF Test Room					
Equipment Manufacturer Model Serial Number Calibration Du					
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016	
RF cable	TCT	RE-06	N/A	Sep. 12, 2016	
Antenna Connector	тст	RFC-01	N/A	Sep. 12, 2016	



6.8. Pseudorandom Frequency Hopping Sequence

Test Requirement:

FCC Part15 C Section 15.247 (a)(1) requirement:

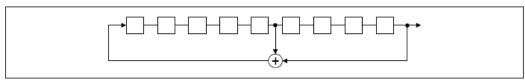
Frequency hopping systems shall have hopping channel carrier frequencies separated by a minimum of 25 kHz or the 20 dB bandwidth of the hopping channel, whichever is greater.

Alternatively. Frequency hopping systems operating in the 2400-2483.5 MHz band may have hopping channel carrier frequencies that are separated by 25 kHz or two-thirds of the 20 dB bandwidth of the hopping channel, whichever is greater, provided the systems operate with an output power no greater than 125 mW. The system shall hop to channel frequencies that are selected at the system hopping rate from a Pseudorandom ordered list of hopping frequencies. Each frequency must be used equally on the average by each transmitter. The system receivers shall have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shall shift frequencies in synchronization with the transmitted signals.

EUT Pseudorandom Frequency Hopping Sequence

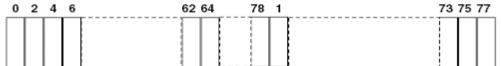
The pseudorandom sequence may be generated in a nine-stage shift register whose 5th and 9th stage outputs are added in a modulo-two addition stage. And the result is fed back to the input of the first stage. The sequence begins with the first one of 9 consecutive ones; i.e. the shift register is initialized with nine ones.

- Number of shift register stages: 9
- Length of pseudo-random sequence: 2⁹-1 = 511 bits
- Longest sequence of zeros: 8 (non-inverted signal)



Linear Feedback Shift Register for Generation of the PRBS sequence

An example of Pseudorandom Frequency Hopping Sequence as follow:



Each frequency used equally on the average by each transmitter. The system receivers have input bandwidths that match the hopping channel bandwidths of their corresponding transmitters and shift frequencies in synchronization with the transmitted signals.



6.9. Conducted Band Edge Measurement

6.9.1. Test Specification

FCC Part15 C Section 15.247 (d)				
ANSI C63.10:2013 and DA00-705				
In any 100 kHz bandwidth outside the intentional radiation frequency band, the radio frequency power shall be at least 20 dB below the highest level of the radiated power. In addition, radiated emissions which fa in the restricted bands must also comply with the radiated emission limits.				
Spectrum Analyzer EUT				
Transmitting mode with modulation				
 The testing follows the guidelines in Band-edge Compliance of RF Conducted Emissions of FCC Public Notice DA 00-705 Measurement Guidelines. Set to the maximum power setting and enable the EUT transmit continuously. Set RBW = 100 kHz (≥1% span=10MHz), VBW = 300 kHz (≥RBW). Band edge emissions must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100kHz RBW. The attenuation shall be 30 dB instead of 20 dB when RMS conducted output power procedure is used. Enable hopping function of the EUT and then repeat step 2 and 3. Measure and record the results in the test report. 				
PASS				

6.9.2. Test Instruments

RF Test Room					
Equipment Manufacturer Model Serial Number Calibration Due					
Spectrum Analyzer	R&S	FSU	200054	Sep. 11, 2016	
RF cable	тст	RE-06	N/A	Sep. 12, 2016	
Antenna Connector	TCT	RFC-01	N/A	Sep. 12, 2016	



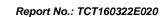
6.10. Conducted Spurious Emission Measurement

6.10.1. Test Specification

Test Requirement:	FCC Part15 C Section 15.247 (d)
Test Method:	ANSI C63.10:2013 and DA00-705
Limit:	In any 100 kHz bandwidth outside the intentional radiation frequency band, the radio frequency power shall be at least 20 dB below the highest level of the radiated power. In addition, radiated emissions which fall in the restricted bands must also comply with the radiated emission limits.
Test Setup:	Spectrum Analyzer EUT
Test Mode:	Transmitting mode with modulation
Test Procedure:	 The testing follows the guidelines in Spurious RF Conducted Emissions of FCC Public Notice DA 00-705 Measurement Guidelines The RF output of EUT was connected to the spectrum analyzer by RF cable and attenuator. The path loss was compensated to the results for each measurement. Set to the maximum power setting and enable the EUT transmit continuously. Set RBW = 100 kHz, VBW = 300kHz, scan up through 10th harmonic. All harmonics / spurs must be at least 20 dB down from the highest emission level within the authorized band as measured with a 100 kHz RBW. Measure and record the results in the test report. The RF fundamental frequency should be excluded against the limit line in the operating frequency band.
Test Result:	PASS

6.10.2. Test Instruments

	RF Test Room										
Equipment	Manufacturer	Model	Serial Number	Calibration Due							
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016							
RF cable	тст	RE-06	N/A	Sep. 12, 2016							
Antenna Connector	TCT	RFC-01	N/A	Sep. 12, 2016							

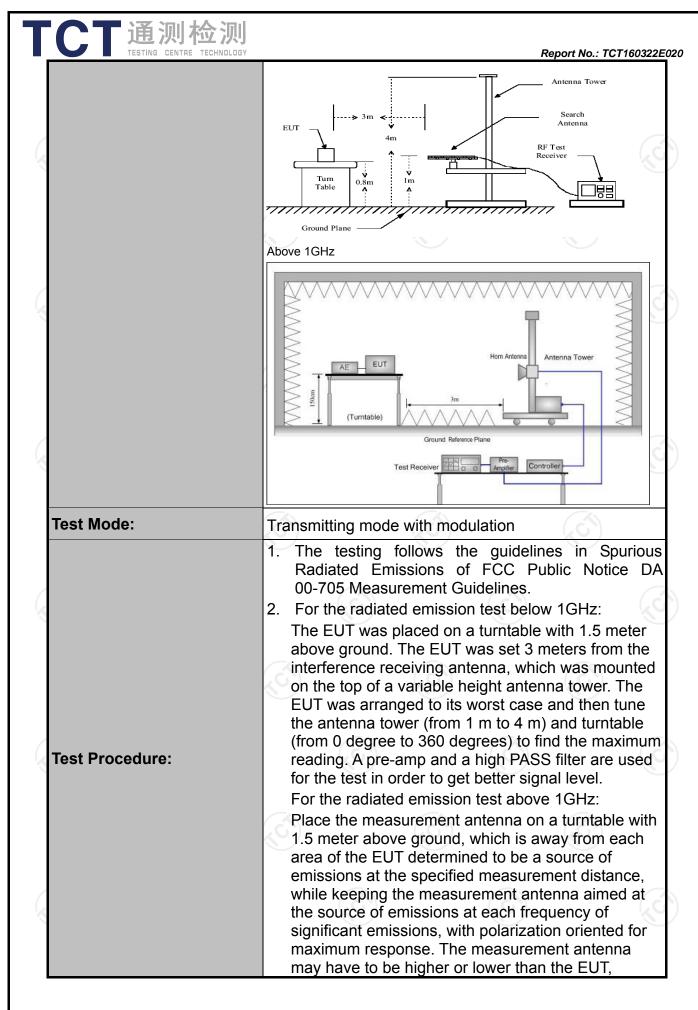


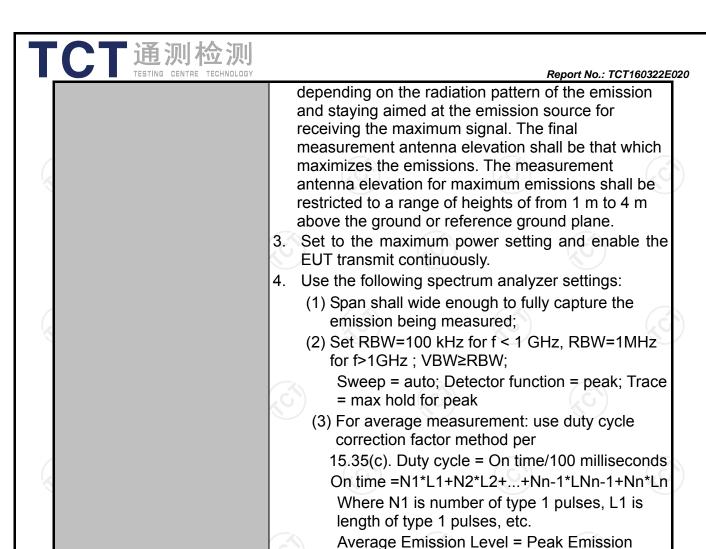


6.11. Radiated Spurious Emission Measurement

6.11.1. Test Specification

<u> </u>		<u> </u>					
Test Requirement:	FCC Part15	C Sect	ion ′	15.209	(0)		EC.
Test Method:	ANSI C63.4:	2014 a	and A	ANSI C6	3.10: 20	13	
Frequency Range:	9 kHz to 25	GHz		Š)			
Measurement Distance:	3 m		10			160	
Antenna Polarization:	Horizontal &	Vertica	al				
	Frequency	Detec		RBW	VBW	_	Remark
Receiver Setup:	9kHz- 150kHz Quas 150kHz- Quas 30MHz		eak eak	200Hz 9kHz	1kHz 30kHz		si-peak Value si-peak Value
p.	30MHz-1GHz	Quasi-p	eak	100KHz	300KHz	Quas	si-peak Value
	Above 1GHz	Pea		1MHz	3MHz		eak Value
	715070 10112	Pea	Κ	1MHz	10Hz	Ave	erage Value
	Frequer	ісу		Field Stre (microvolts	-		asurement nce (meters)
	0.009-0.490			2400/F(F	(Hz)	300	
	0.490-1.705			24000/F(KHz)		30
	1.705-30			30 100		30	
	30-88 88-216			100			3
Limit:		216-960					3
		Above 960					3
	Frequency		Field Strength microvolts/meter)		Measure Distan (meter	ce	Detector
	Above 1GH	z		500	3		Average
	For radiated emi	ssions be		000 0MHz	3	(c	Peak
	Di	istance = 3m				Compu	ater
Test setup:	EUT	Turn table	Fround P	lane		Amplifier	
	30MHz to 1GHz			,			





Loss + Read Level - Preamp Factor = Level

Test results:
PASS



Level + 20*log(Duty cycle)

Corrected Reading: Antenna Factor + Cable



6.11.2. Test Instruments

Report No.: TCT160322E020

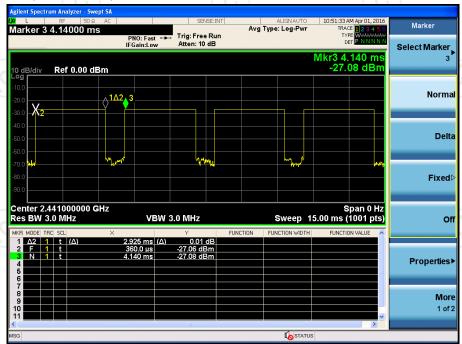
	Radiated Em	ission Test Si	te (966)	
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due
ESPI Test Receiver	ROHDE&SCHW ARZ	ESVD	100008	Sep. 11, 2016
Spectrum Analyzer	ROHDE&SCHW ARZ	FSEM	848597/001	Sep. 11, 2016
Spectrum Analyzer	Agilent	N9020A	MY49100060	Sep. 12, 2016
Pre-amplifier	EM Electronics Corporation CO.,LTD	EM30265	07032613	Sep. 11, 2016
Pre-amplifier	HP	8447D	2727A05017	Sep. 11, 2016
Loop antenna	ZHINAN	ZN30900A	12024	Sep. 13, 2016
Broadband Antenna	Schwarzbeck	VULB9163	340	Sep. 13, 2016
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Sep. 13, 2016
Horn Antenna	Schwarzbeck	BBHA 9170	373	Sep. 13, 2016
Antenna Mast	CCS	CC-A-4M	N/A	N/A
Coax cable	TCT	RE-low-01	N/A	Sep. 11, 2016
Coax cable	TCT	RE-high-02	N/A	Sep. 11, 2016
Coax cable	TCT	RE-low-03	N/A	Sep. 11, 2016
Coax cable	тст	RE-high-04	N/A	Sep. 11, 2016
EMI Test Software	Shurple Technology	EZ-EMC	N/A	N/A



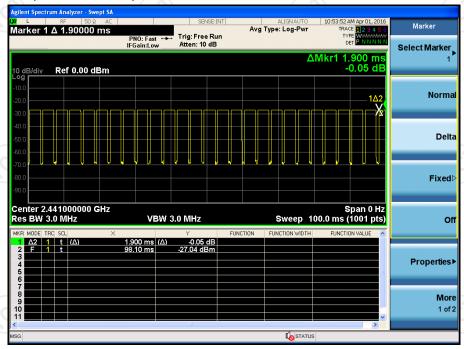
6.11.3. Test Data

Duty cycle correction factor for average measurement

3DH5 on time (One Pulse) Plot on Channel 00



3DH5 on time (Count Pulses) Plot on Channel 00



Note:

- 1. Worst case Duty cycle = on time/100 milliseconds = (2.925*26+1.9)/100=0.7795
- 2. Worst case Duty cycle correction factor = 20*log (Duty cycle) = -2.16dB
- 3. 3DH5 has the highest duty cycle worst case and is reported.
- 4. The average levels were calculated from the peak level corrected with duty cycle correction factor (-2.16dB) derived from 20log (dwell time/100ms). This correction is only for signals that hop with the fundamental signal, such as band-edge and harmonic. Other spurious signals that are independent of the hopping signal would not use this correction.

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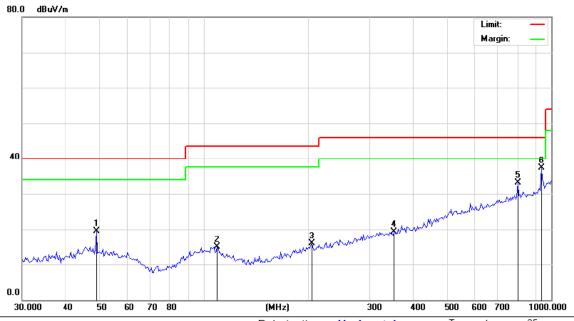
Report No.: TCT160322E020



Please refer to following diagram for individual

Below 1GHz

Horizontal:



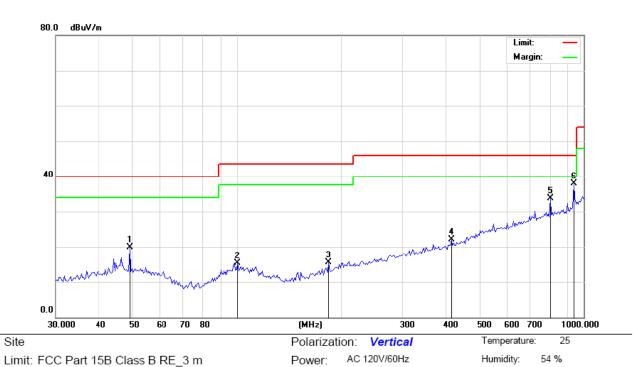
Site Polarization: Horizontal Temperature: 25
Limit: FCC Part 15B Class B RE_3 m Power: AC 120V/60Hz Humidity: 54 %

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		49.0626	31.52	-12.08	19.44	40.00	-20.56	peak		0	
2		109.3110	26.91	-11.96	14.95	43.50	-28.55	peak		0	
3		204.3052	27.41	-11.53	15.88	43.50	-27.62	peak		0	
4		353.4471	26.43	-7.16	19.27	46.00	-26.73	peak		0	
5		804.2522	31.51	1.51	33.02	46.00	-12.98	peak		0	
6	*	938.7138	33.36	3.99	37.35	46.00	-8.65	peak		0	





Vertical:



No.	Mk	. Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		Antenna Height	Table Degree	
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	cm	degree	Comment
1		49.0626	31.98	-12.08	19.90	40.00	-20.10	peak		0	
2		100.4711	26.70	-11.46	15.24	43.50	-28.26	peak		0	
3		183.8660	28.20	-12.79	15.41	43.50	-28.09	peak		0	
4		415.4485	27.70	-5.69	22.01	46.00	-23.99	peak		0	
5		804.2522	32.20	1.51	33.71	46.00	-12.29	peak		0	
6	*	938.7138	34.00	3.99	37.99	46.00	-8.01	peak		0	

Note: 1.The low frequency, which started from 9KHz~30MHz, was pre-scanned and the result which was 20dB lower than the limit line per 15.31(o) was not reported







Above 1GHz

Modulation	Type: Pi/	4 DQPSK							
Low chann	el: 2402 M	1Hz							
Frequency (MHz)	Ant. Pol. H/V	Peak reading (dBµV)	AV reading (dBuV)	Correction Factor (dB/m)	Peak	n Level AV (dBµV/m)	Peak limit (dBµV/m)	AV limit (dBµV/m)	Margin (dB)
2390	Н	45.66		-8.27	37.39		74	54	-16.61
4804	Н	47.42		0.66	48.08		74	54	-5.92
7206	Н	37.8		9.5	47.3		74	54	-6.7
	, CH)		+, G		(·C `}-		(, C)	
					× ×				
2390	V	44.51		-8.27	36.24		74	54	-17.76
4804	V	42.86		0.66	43.52		74	54	-10.48
7206	V	37.73		9.5	47.23		74	54	-6.77
(0)	V			1/2)		(C)		\/\(\)

Middle cha	Middle channel: 2441 MHz										
Frequency (MHz)	Ant. Pol. H/V	Peak reading (dBµV)	AV reading (dBµV)	Correction Factor (dB/m)	Emissic Peak (dBµV/m)	AV	Peak limit (dBµV/m)	AV limit (dBµV/m)	Margin (dB)		
4882	Ŧ	45.75		0.99	46.74		74	54	-7.26		
7323	Η	39.21	-	9.87	49.08	I	74	54	-4.92		
	Η		-			-	I				
									(ć		
4882	V	44.88		0.99	45.87		74	54	-8.13		
7323	V	38.6		9.87	48.47		74	54	-5.53		
	V										

High chann	nel: 2480 N	ЛHz	(.G	*)		.61		(.G))	
Frequency (MHz)	Ant. Pol. H/V	Peak reading (dBµV)	AV reading (dBµV)	Correction Factor (dB/m)	Peak	n Level AV (dBµV/m)	Peak limit (dBµV/m)	AV limit (dBµV/m)	Margin (dB)
2483.5	Н	47.76		-7.83	39.93		74	54	-14.07
4960	Н	50.04		1.33	51.37		74	54	-2.63
7440	Н	41.93		10.22	52.15		74	54	-1.85
	Н								
						_			
2483.5	V	49.77		-7.83	41.94		74	54	-12.06
4960	V	45.65	-420	1.33	46.98	(O-7	74	54	-7.02
7440	V	36.81		10.22	47.03	<u></u>	74	54	-6.97
	V	I							

Note:

- 1. Emission Level=Peak Reading + Correction Factor; Correction Factor= Antenna Factor + Cable loss Pre-amplifier
- 2. Margin (dB) = Emission Level (Peak) (dB μ V/m)-Average limit (dB μ V/m)
- 3. The emission levels of other frequencies are very lower than the limit and not show in test report.
- 4. Measurements were conducted from 1 GHz to the 10th harmonic of highest fundamental frequency.
- 5. Data of measurement shown "---"in the above table mean that the reading of emissions is attenuated more than 20 dB below the limits or the field strength is too small to be measured.
- Measurements were conducted in all three modulation (GFSK, Pi/4 DQPSK, 8DPSK), and the worst case Mode (Pi/4 DQPSK) was submitted only.

*****END OF REPORT****

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Appendix A: Test Result of Conducted Test 20dB Occupied Bandwidth

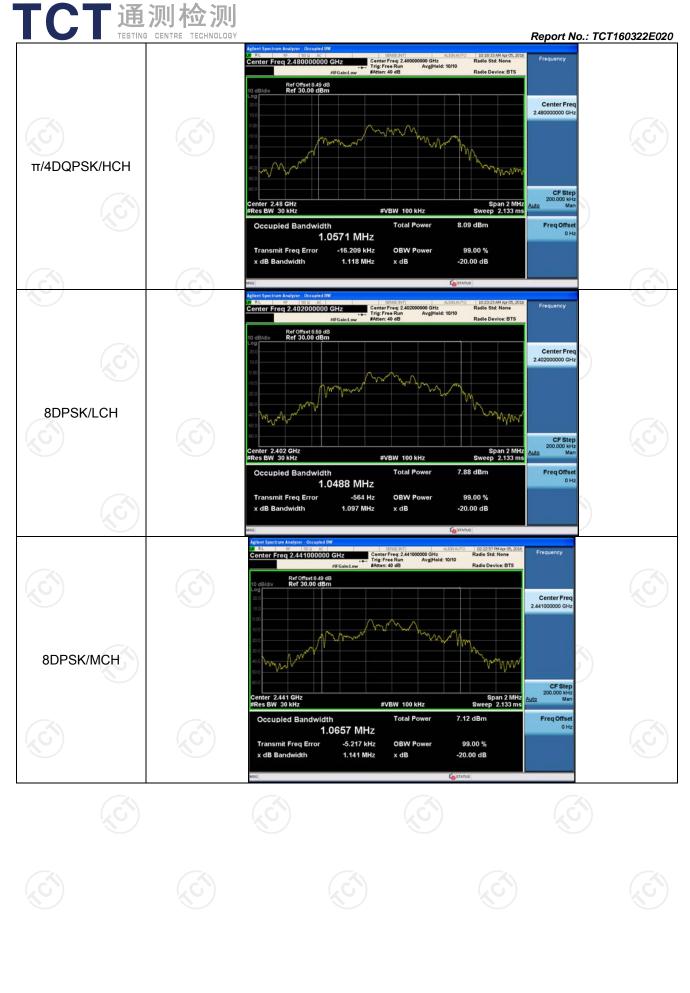
Test Result

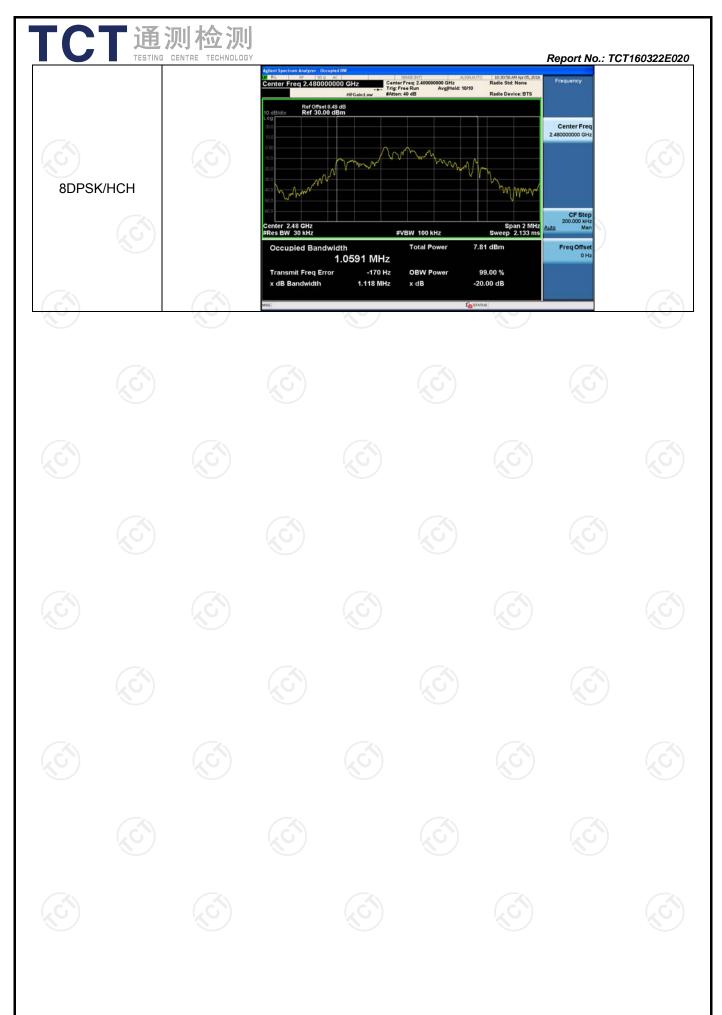
Mode	Channel.	20dB Bandwidth [MHz]	0dB Bandwidth [MHz] 99% OBW [MHz]	
GFSK	LCH	0.7122	0.82356	PASS
GFSK	MCH	0.7900	0.85035	PASS
GFSK	HCH	0.7541	0.83034	PASS
π /4DQPSK	LCH	1.135	1.0775	PASS
π/4DQPSK	MCH	1.152	1.0824	PASS
π/4DQPSK	HCH	1.118	1.0571	PASS
8DPSK	LCH	1.097	1.0488	PASS
8DPSK	MCH	1.141	1.0657	PASS
8DPSK	HCH	1.118	1.0591	PASS

Test Graph











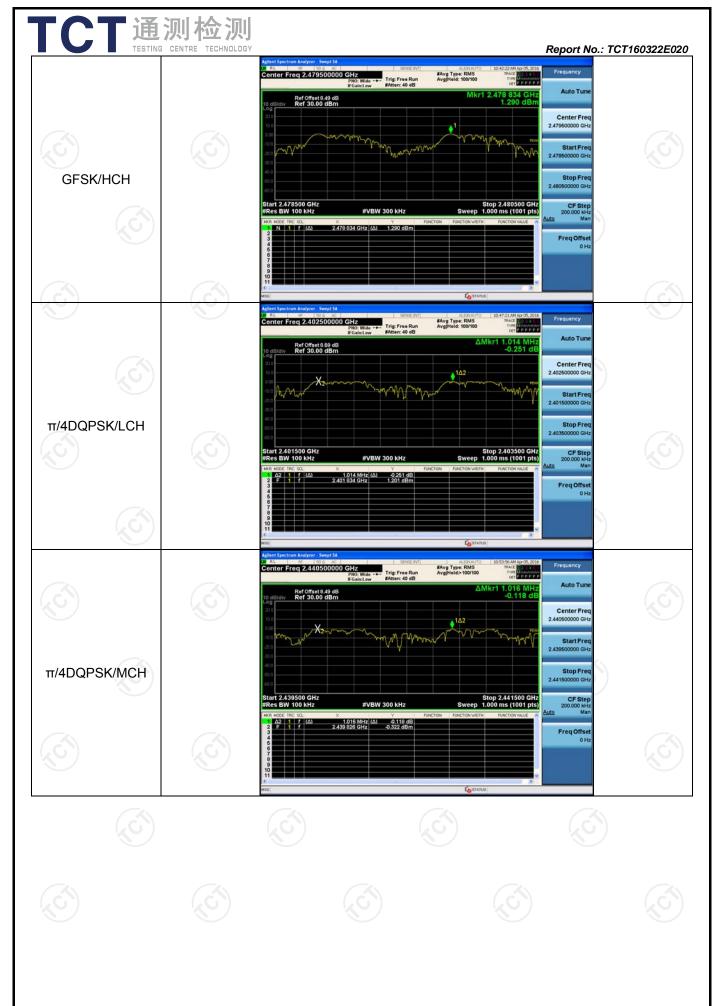
Carrier Frequency Separation

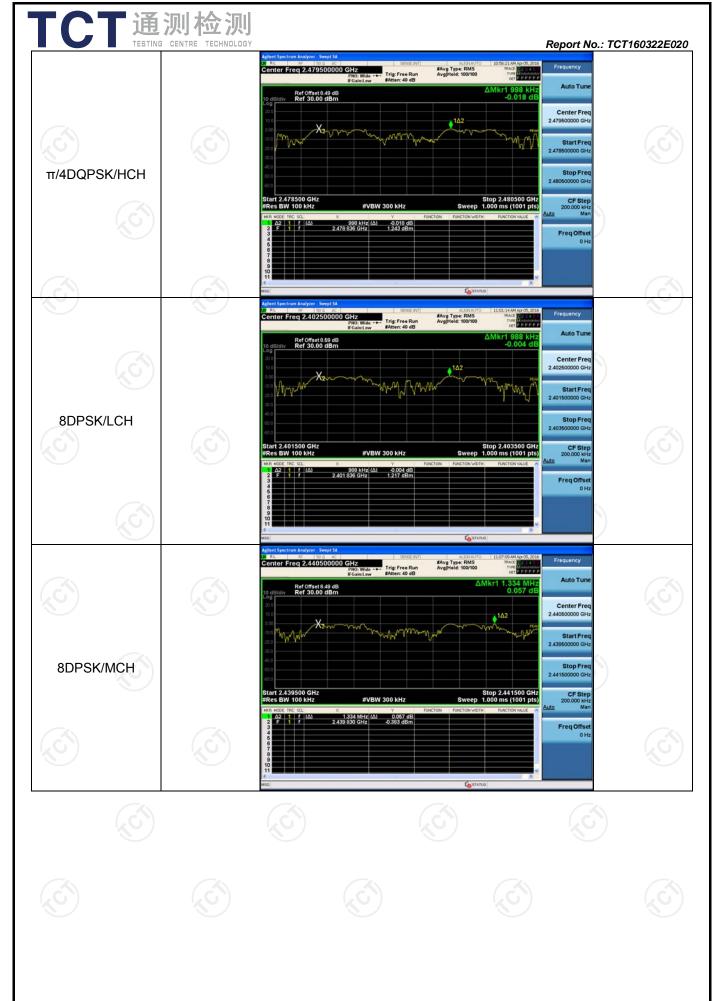
Result Table

Mode	Channel.	Carrier Frequency Separation [MHz]	Verdict
GFSK	LCH	1.000	PASS
GFSK	MCH	1.000	PASS
GFSK	HCH	1.000	PASS
π/4DQPSK	LCH	1.014	PASS
π/4DQPSK	MCH	1.016	PASS
π/4DQPSK	HCH	0.998	PASS
8DPSK	LCH	0.988	PASS
8DPSK	MCH	1.334	PASS
8DPSK	HCH	1.162	PASS

Test Graph











Dwell Time

Result Table

The Dwell Time=Burst Width*Total Hops. The detailed calculations are showed as follows:

- The duration for dwell time calculation:0.4[s]*hopping number=0.4[s]*79[ch]=31.6[s*ch];
- The burst width [ms/hop/ch], which is directly measured, refers to the duration on one channel hop.
- The hops per second for all channels: The selected EUT Conf uses a slot type of 5-Tx&1-Rx and a hopping rate of 1600 [ch*hop/s] for all channels. So the final hopping rate for all channels is 1600/6=266.67 [ch*hop/s]
- The hops per second on one channel: 266.67 [ch*hops/s]/79 [ch]=3.38 [hop/s];
- The total hops for all channels within the dwell time calculation duration:3.38 [hop/s]*31.6[s*ch]=106.67 [hop*ch];
- The dwell time for all channels hopping: 106.67 [hop*ch]*Burst Width [ms/hop/ch].

Mode	Channel	Burst Width [ms/hop/ch]	Total Hops [hop*ch]	Dwell Time[s]	Duty Cycle [%]	Verdict
GFSK	LCH	2.96	106.7	0.316	78.95	PASS
GFSK	MCH	2.961	106.7	0.316	78.96	PASS
GFSK	HCH	2.959	106.7	0.316	78.92	PASS
π/4DQPSK	LCH	2.954	106.7	0.315	78.76	PASS
π/4DQPSK	MCH	2.954	106.7	0.315	78.78	PASS
π/4DQPSK	HCH	2.954	106.7	0.315	78.78	PASS
8DPSK	LCH	2.954	106.7	0.315	78.78	PASS
8DPSK	MCH	2.954	106.7	0.315	78.78	PASS
8DPSK	HCH	2.955	106.7	0.315	78.79	PASS

Test Graph

